

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet 1

of 2

<i>Complete if Known</i>	
Application Number	10/573,314
Filing Date	September 28, 2007
First Named Inventor	Derek M. Blaha
Art Unit	3739
Examiner Name	Michael F. Peffley
Attorney Docket Number	2927 (1850-11 PCTUS)

U.S. PATENT DOCUMENTS WITHOUT REFERENCES

FOREIGN PATENT DOCUMENTS WITH REFERENCES

Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)				
		GB 702 510	01-20-1954	Foxboro Co.		

Examiner	Date Considered
----------	-----------------

Examiner: Initial if citation considered, whether or nor citation is in conformance with MPEP §609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet 2

of 2

Complete if Known

Application Number	10/573,314
Filing Date	September 28, 2007
First Named Inventor	Derek M. Blaha
Art Unit	3739
Examiner Name	Michael F. Peffley
Attorney Docket Number	2927 (1850-11 PCTUS)

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
		HADLEY, I C D ET AL., "Inexpensive Digital Thermometer for Measurements on Semiconductors", <i>International Journal of Electronics</i> , Vol. 70, No. 6, 1155-1162 (1991).	

Examiner	Date Considered
Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP §609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.	